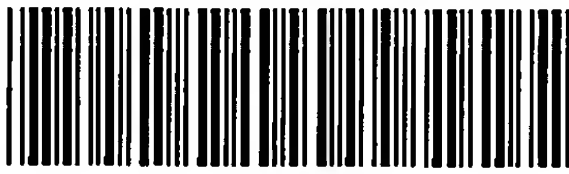


<b>Issue Classification</b> 	Application No.	Applicant(s)	
	10/065,870	ARKIN ET AL.	
	Examiner	Art Unit	
	Jinhee J Lee	2831	

ISSUE CLASSIFICATION									
ORIGINAL					CROSS REFERENCE(S)				
CLASS		SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)			
174		135			174	178	153R	138E	
INTERNATIONAL CLASSIFICATION					24	303			
H	0	1	B	7/00					
				/					
				/					
				/					
				/					

Jinhee Lee (Assistant Examiner) (Date)	<i>Dean A. Reichard</i> DEAN A. REICHARD 8/23/04 SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2800 (Primary Examiner) (Date)	Total Claims Allowed: 1
<i>Devin E. ...</i> 8/23/04 (Legal Instruments Examiner) (Date)		O.G. Print Claim(s) 17
		O.G. Print Fig. 13

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant				<input type="checkbox"/> CPA				<input type="checkbox"/> T.D.				<input type="checkbox"/> R.1.47			
Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original
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	2		32		62		92		122		152		182		
	3		33		63		93		123		153		183		
	4		34		64		94		124		154		184		
	5		35		65		95		125		155		185		
	6		36		66		96		126		156		186		
	7		37		67		97		127		157		187		
	8		38		68		98		128		158		188		
	9		39		69		99		129		159		189		
	10		40		70		100		130		160		190		
	11		41		71		101		131		161		191		
	12		42		72		102		132		162		192		
	13		43		73		103		133		163		193		
	14		44		74		104		134		164		194		
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	26		56		86		116		146		176		206		
	27		57		87		117		147		177		207		
	28		58		88		118		148		178		208		
	29		59		89		119		149		179		209		
	30		60		90		120		150		180		210		